

Special Issue

Special Issue on the 2017 International Image Sensor Workshop (IISW)

Message from the Guest Editors

The International Image Sensor Workshop (IISW) is the world's largest technology forum, fully devoted to image sensor design and research. The workshop papers span across a wide range of imaging devices: From small pixel mobile image sensors to large format X-ray and astronomy imagers, from sensors for high end scientific applications to low-cost mass produced stacked sensors, from time-resolving and photon counting imagers to rad-hard sensors for space applications.

This Special Issue provides the expanded versions of 20 invited papers from the workshop covering novel and innovative approaches in image sensors, as well as state-of-the-art incremental improvements on known techniques. Other paper submissions are strictly limited to IISW 2017 participants.

Guest Editors

Mr. Vladimir Koifman

Prof. Dr. Shoji Kawahito

Dr. Daniel Van Blerkom

Dr. Guy Meynants

Deadline for manuscript submissions

closed (31 October 2017)



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Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

Editor-in-Chief

Prof. Dr. Vittorio M. N. Passaro

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